# A Complete Bibliography of Publications in *Technometrics* for the decade 1980–1989

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## Title word cross-reference

**#9312** [Hsi80].

($\geq 2$) [Sin92]. $2^{k-p}$ [FH80]. $A$ [HM84]. $\bar{X}$ [RAAN88, San89, BR89, BR88]. $\beta$ [Mee84a, OCO89]. $C_p$ [Wei81]. $D$ [CN80, DA88, GK80a, Hil80, JN83, Khu84, VDY81, Wel82]. $F$ [LM80, WD81]. $K$ [All84, Gen80, GL84a, GL84b, HLG85, Hoc84, Wei84, Hsi86, Sax81, Sin92]. $k(\geq 2)$ [Sin83]. $l$ [CO86]. $\Lambda$ [RL80]. $M$ [MRR80, DM87, DM88, Sax81]. Pr(Y < X) [RG86]. $p$ [DM87, DM88]. $p^{n-m}$ [Fra84, Fra85]. $R$ [San89, DM87, DM88]. $R^2$ [Agr86a, RP80]. $S_B$ [Mag80]. $t$ [BJ87, Koe83, Wil83]. $|X'X|$ [Bat83].

**-Clustering** [All84, GL84b, Hoc84, Wei84, GL84a, HLG85]. **-Content** [Mee84a]. **-Control** [BR88, BR89]. **-Estimators** [MRR80]. **-Expectation** [Mee84a, OCO89]. **-Optimal** [CN80, HM84, Hil80, JN83, Khu84, VDY81].

**-optimality** [Wel82]. **-Optimum** [DA88, GK80a].
[**?**]out-of-Saxena:1981:DFT. **-to-Enter** [WD81]. **-Type** [Agr86a].

**1** [Har83]. **105D** [JT83]. **12** [Pri81]. **12th** [Fed81j]. **15** [Hsi80]. **17th** [Zie89c]. **1964** [Boa85b]. **1979** [Ber83, Fed80c]. **1980** [Fed81d, Fed84d, Par83]. **1981** [Aro84a, Han84a]. **1982** [Fed84e].

**21** [Kit81]. **22** [FHL81]. **23** [EL83, HL84]. **24** [LM85, Fed82b]. **25** [Sin92]. **28** [BM87b, Cro89]. **29** [DM88, Ste90].

**3** [Aro84c, Fed81c, Liu89]. **30** [BR89, NP89, WB88a]. **31** [BT98]. **39** [IC89].

**4** [Aro84d, Zie88-28].

**5** [Aro86a, Sch86b]. **51** [Hsi80].

**6** [Aro86b].

**79** [Hea82].

**80f** [Kit81]. **81i** [FHL81]. **82f** [EL83]. **84e** [LM85]. **84f** [HL84]. **84g** [Sin92]. **88e** [Ste90].

**90e** [BR89]. **90f** [BT98].

**Aberration** [Fra84, FH80]. **Absolute** [NW79, NW85, Par88a]. **Abstract** [Roh82]. **Accelerated** [Kan87a, Mee84b, Sch86d]. **Acceptance** [Ber82a, Car87a, NA88, SY87, Per84]. **Accountancy** [Hen86]. **Accumulation** [HW86]. **Accuracy** [Aro85c, CP81]. **Accurate** [FM80a]. **ACE** [dVS89]. **Acquisitions** [Sch84e]. **Acreage** [Chh86]. **Action** [Zie89w]. **Ad** [Ing81]. **Adaptive** [HMW80, Lou84, MRR80, Win87]. **Added** [JM87]. **Added-Variable** [JM87]. **Adding** [Wan85]. **Additive** [FS89a, FS89b, Has89, Haw89]. **Adequacy** [Lee80b]. **Adequate** [HJF80, SD80]. **Adjustment** [Boa87, BF87, Deh87b, DA88, Eas87, LSK87b, PR87, Wu87, LSK87a]. **Administration** [PS87]. **Advanced** [Zie89h, vT88, Jac85a]. **Advances** [FTK89, Web83, Yfa87, Roh80]. **Aerial** [Hai87b]. **Afifi** [Cru82, Jac85b]. **Age** [J.80e]. **Agostino** [Jac85c]. **Agresti** [McC85]. **Agricultural** [Koc81]. **Agriculture** [Fed81i]. **AIC** [Kit81, Kit79]. **Aickin** [Gar85]. **Aided** [CN89, Wel84, Jac85b]. **Aikin** [Zie87e]. **Air** [Cle80, Hor80a, Hor80b]. **Aitchison** [Pie88a]. **Aitkin** [Ano81e]. **Akaike** [Bro89]. **Alan** [Gbu83, Gos86, McC85, Zie89h]. **Alfréd** [Jon89a]. **Algebra** [Cas80, Jac80c, Nel81, Sch85e]. **Algorithm** [AW80, BS81, DA88, Hai87a, NGG83]. **Algorithms**

[CN80, Lak87, Lin81a, Gra87b, Mee86, Zie88w]. **Ali** [Maz89]. **Allan** [Iye87, Jac80d, Tuc82]. **Allen** [MM83b, War87b, Zie89c]. **Allied** [Scl81a]. **Allocating** [Wei81]. **Allocations** [BT83]. **Aloke** [Nac87b, Pro89c]. **Alternative** [DG87]. **Alternatives** [Ski80, Low83b]. **Alvey** [Dri89]. **Aman** [Web83]. **Amendola** [Rig89]. **American** [Fed84a]. **among** [Far85, QK82]. **Amount** [PC85, Pie88b]. **Amsden** [Lee89a, Lee89a]. **Analyses** [GM87, HI87, MS89, Joh89, Yfa87, Zie88b]. **Analysis** [AW89, Ait81, Aro84c, Aro84d, Aro86b, Aro86a, Atk83, BNC87, BLSF88, Ber89b, Bin89, Bis83, BM86a, Caf87, Cal88, CR85, CCMC86, Chh86, Cle80, Cre87, Cru82, Dic82, DGH85, Eas81, EK82, Fed80a, Fed81k, Fed81e, Fed84e, Gar85, Gho88, Goo87, Gun88a, Gun85b, HMS81, HW86, Han85b, Han86, Hei80b, Hil81, Hin80, Hoe87, HI87, Hor80a, Hor80b, HL81b, HL81a, Ize89, Jac85c, Jac85e, Jac86b, Jac86a, Kad84, Kle82, Kot88, Lac82, LC81, Law81, Len89, Lin81a, Lom88, Low83b, Luc81, Lwi81, LM82, Mac81, MWF88, Maz89, Mea89, Mey88, Mie82, Mil80, Mil81, Mul89, Nac87a, NW85, Nel85, Nel88, Orb81, Pag85, Par83, Pie88a, Pre83b, Pro87d, Ree88, RL80, RS81, Sal86, Sch87b, Sch86d, Shu87, Sid84, Ste89b, TW87, Tup89, Wal89, War87b, Wei83, WG79]. **Analysis** [Win87, Zem86, Zie86c, Zie86b, Zie87b, Zie88m, Zie88-27, Zie88c, Zie89s, Zie89x, dLNB$^+$81, HL84, LM85, Zie88k, Agr88, Bea83, Ber89a, Bow87, Col88a, Cro80, Deh87a, Dun89, Fed80a, Fed81g, Gib83, Goo88, Gri89, Gri88, Gup82, Gup83, Hah82, Ima86, Jac84, Jac85b, Jac89, Jon88, Lac81, Lak87, Lee81, Lee82, Lee83, Mar88b, Moe83, Par88c, Pry89, Rab89, Sch83a, Sch84f, Sch86a, Sch89c, She89, Sin81, SG80, Tuc82, Zie89d, Zie89r, Zie89l, Abr81, Gok83, Kat82, McC85, Roc87a, Sch85a]. **Analysis-Plackett** [Zie87b]. **Analysis-V** [Fed80a]. **Analytes** [Ven82]. **Analytical** [Min87, Zie89m, Yfa87]. **Analyze** [Kan87b, Pro87b]. **Analyzing** [NP88b, NP89, Oma84, Sin87, MM83b]. **Anatomy** [Eas80a]. **Andersen** [Aro85c]. **Anderson** [Aro84a, Aro86b, Par83, Pro88a, Ree88, Zah89, Aro84c, Aro84d, Aro86a, Fed80c, Fed81d, Fed84e, J.80b, Sch86a, Zie85a, Zie89m]. **Andersson** [Gro89]. **André** [Joh89]. **Andrew** [She89]. **Andrews** [Sch87a, Zie87a, Lit85]. **Angewandte** [Sch84b]. **Angular** [Lom86]. **Ann** [Hin87, Min89]. **Annals** [Fed81a]. **Annealing** [BJS86, Hai87a]. **Annick** [Pie89]. **Annino** [Zie89q]. **Anniversary** [Lam84b]. **Annotated** [Sch85g, Zie89x, Zie89x]. **Annual** [Fed81j]. **ANOVA** [Ams87, BT98, BT89, Mee84a, SM84, WTA80, Zie89x]. **Anscombe** [Gun85a, GK80b]. **Anthony** [Zie86a]. **Any** [GZ79]. **Aoki** [Wel89]. **APL** [Gun85a, Sch82, Sch82]. **APL-STAT** [Sch82]. **Applicable** [Che83]. **Application** [BW85a, BW85b, BJ87, Cle80, DPM80, GH80, Hai87a, Hai87b, HMW80, Hen86, Hoe87, Hor80a, Hor80b, Hub89, JT83, Lee80c, Mac81, McL85, Mee87b, PR82, San89, TW87, Tor89, Yan85, Zem86, Zie85b, dLNB$^+$81, Vin89]. **Applications** [Ano84e, CJJ81, CJ86, Cro82, HR88, Hod87, Ize87, Mee85, Min86, Sch89a, Sch85d, Sid82, Tuc82, Zie88w, Zie89q, Zie89j, Jac86b, Sto80, Aro85a, Bor86, Bre89, Cor87, Fed81a, Gok83, Gun88a, Ize88, Job89, Kad84,

Ker85, Lee89c, McC87, Mee87a, Pen81, Pro88a, Roh80, Han85a, Lew87]. **Applied** [Ams87, Ano80g, Jac85c, Joh87, McD79, Rig88, Sch84a, Sin80, Zie88u, Agr88, Aro84a, Bea83, Bec87, Boe83, Car88, Dun89, Fed81b, Hah82, Lam84a, Mee86, Nac87a, Rus88, Sch81b, Sch85b, Sid84, Wal89, Zie85a, Zie88b, Zie88c]. **Apply** [Pro87c]. **Applying** [Agr86a]. **Approach** [BME85, Boy80, Cha87, LRS82, Lom86, LV86, Rup87, WMS85, Woo84, Yan83, Yfa87, Sin80, Agr89, Cru82, Jac85c, Joh87, Mac81, She87, Wat84]. **Approximate** [BE81, BA89, BR87, DiC87, EM82, MB88, RHM87]. **Approximating** [Cor80]. **Approximation** [BN81, FM80a, GZ79, Koe83, MTL82, Ran82]. **Aproach** [Gru88b]. **Araujo** [Ald81]. **Archetti** [Fed81h]. **Architecture** [Han84b]. **ARIMA** [MHW84]. **ARMA** [DP81, Gla82, Jon80, PD80a]. **Arnold** [Dal87, Gup82, Nac87a]. **Aroian** [Spr83]. **Art** [Har89b, Zie87d]. **Arthur** [Sch89a]. **Artificial** [Zie89b]. **Ascher** [Eas85]. **Asit** [Zie88f]. **Aspects** [Che85, Jac80d, Tit80a, Gle84]. **ASQC** [She81a, Fed84a]. **Assessing** [BH84, SW86]. **Assessment** [DGH85, GJM89]. **Assigning** [PBT85]. **Assignment** [Ber89a]. **assignments** [Wu81]. **Associated** [YSOE84]. **Association** [J.80d]. **Assumptions** [Col88b]. **Assurance** [Zie89o]. **Asymmetric** [MS89]. **Asymmetrical** [AD83, Che89, GND82]. **Asymptotic** [Ano90b, Fed80b, Gok81, HZ80, Koz80, SS89, Sen80]. **Atkinson** [Zie86a, Wei87]. **Attribute** [Sch84c]. **Attributes** [SY87]. **Audit** [Lor80]. **Auditing** [Min87]. **Augmented** [AM80, Mal86]. **August** [Aro84a, Par83]. **Autocorrelations** [Gla82]. **Autoregressions** [New82]. **Autoregressive** [Vec85]. **Available** [SMV82]. **Average** [Cro87, VoR85, Vec85]. **Awardee** [LD80]. **Azen** [Cru82]. **Azencott** [Gra87a].

**B** [Aro83, Bin89, Che83, Coh82, Fed81l, Gup83, Hah81, Han85b, Han86, Hea82, Hub89, Jac85c, Jac85a, Kat82, Liu89, MM83b, Par82, Per82, Pre83b, Sch81a, Sch82, Sch84c, Ste89b, Zie88e, Zie88a, Zie89w]. **Back** [Ano80a, Ano80b, Ano80c, Ano80d, Ano81a, Ano81b, Ano81c, Ano81d, Ano82a, Ano82b, Ano82c, Ano82d, Ano83a, Ano83b, Ano83c, Ano83d, Ano84a, Ano84b, Ano84c, Ano84d, Ano85a, Ano85b, Ano85c, Ano85d, Ano86a, Ano86b, Ano86c, Ano86d, Ano87a, Ano87b, Ano87c, Ano87d, Ano88a, Ano88b, Ano88c, Ano88d, Ano89a, Ano89b, Ano89c, Ano89d]. **Backwards** [Ano90a, Sim88a]. **Backwards-Stepping** [Ano90a, Sim88a]. **Bain** [Zie88s]. **Balakrishnan** [Roc87b]. **Balanced** [BT89, Mee84a, SM81, BT98, Wu81]. **Baldessori** [Joh82]. **Banach** [Ald81]. **Bancroft** [Sin82]. **Bands** [CI83, Che87, CI88, Dal83, Nai84, Pie86]. **Banks** [Mor84]. **Barker** [Law86c]. **Barndorff** [Mat80]. **Barndorff-Nielsen** [Mat80]. **Barnett** [Sch86c, You80]. **Barrie** [Gun88a]. **Bártfai** [Fed82b]. **Bartholomew** [Jac89]. **Based** [Bai80b, BE81, BLSF88, EBW81, Har89a, HGB89, Hor86, Hsi86, KE80, LM80, MRR80, New80, Pie87, Rup87, SH83, ST86, Sin83, Tit80b, Sin92, Wel82, Lee89b]. **Bases** [Rig89]. **BASIC**

[Smi88, Gro89, Har80, Low82, She81a, Sto80, Sin80, Maz87, McL89, Gru88b, Hei80b, Mye80]. **Basics** [Ams87, Was89]. **Basu** [Zie88f]. **Bates** [BSBW86]. **Bathtub** [Hjo80]. **Bathtub-Shaped** [Hjo80]. **Batschelet** [Wat82]. **Bayes** [Bru86, GM87, Mil89, Han89]. **Bayesian** [Ber89b, Car87a, Eas81, Hil81, HL81a, HL84, Law81, Lwi81, Orb81, RS81, Ber87, Cha87, CB80, EN80, HI87, HL81b, MWF88, Mil80, RPL81, SS81, WMS85, Ber83, Sch83a]. **Bayne** [Zie88e]. **Be** [HW86]. **Beattie** [WW89]. **Bechhofer** [Ano82e]. **Beckman** [Ano90c]. **Behavioral** [Bow83, Hei80b, Mul89]. **Behrens** [BR87]. **Bendat** [Iye87, Tuc82]. **Bensoussan** [Fed81b]. **Berbee** [Sys82]. **Berger** [Hsi87, Ber82c]. **Bernard** [Cre87, Deh87a, J.80a, Obr82a]. **Bernardo** [Ber83]. **Bernhard** [Sch84b]. **Bernoulli** [KN84]. **Berry** [Obr82a]. **Bertrand** [Vin89]. **Best** [Dud80, RP80]. **Betteley** [Scl81a]. **between** [Atk81, EJG84, MHW84]. **Beyer** [Zie89f]. **Beyond** [Ams87]. **Bias** [DS88, McL80, RL80, YB87]. **Biased** [HSH86]. **Bibby** [Cop83, Lee81]. **Bibliographical** [Far85]. **Bibliography** [Sch85g, J.80a]. **Bidding** [Ano84e, CJJ81]. **Biles** [Bis81]. **Binary** [BA89, GC85, Mea89]. **Binomial** [Atw86, JT83, Kre87, MWF88]. **Bio** [Syl81]. **Bio-Sciences** [Syl81]. **Bioenergetics** [YSOE84]. **Biology** [Wat82]. **Biomedical** [Hea82, Mye80, Zie89s]. **Biostatistics** [Hei80b, Klo82, Zie88m]. **Birnbaum** [Eas80b, EBW81]. **Birth** [Hun83]. **Bivar** [You82]. **Bivariate** [LM80]. **Blanton** [Syl87]. **Blending** [Sne81, Zem86]. **Blinchikoff** [Zie88p]. **Block** [BT81, Dea81, HM84, Pro89c, SM81]. **Blocked** [Lee80c]. **Blocking** [CN89]. **BMDP** [Zie88b, Cru84, Hea82]. **BMDP-79** [Hea82]. **Board** [EJG84]. **Bocklebank** [Dow88]. **Body** [WP88]. **Boen** [Gun84]. **Bolton** [Ker85]. **Bolyai** [Fed82b]. **Bonferroni** [CP81]. **Book** [Abr81, Agr89, Agr88, Ald81, Ams87, And86, Ang88, Ang89, Aro83, Aro84a, Aro84c, Aro84d, Aro84b, Aro85a, Aro85d, Aro85b, Aro85c, Aro86b, Aro86a, Asc89, Bai80a, Bas86, Bas88, Bat88, Bea83, Bec87, Bem89, Ber89a, Ber82b, Ber89b, Ber82c, Ber83, Bil84, Bil88a, Bil88b, Bin89, Bis89, Bis81, Bis83, Boa85b, Boa85a, Boe83, Bon81, Boo88, Bor86, Bor87, Bor89, Bow87, Bow83, Boy80, Bre89, Bro89, Bry89, Bul89, Caf87, Cal88, Car88, Car87a, Car87b, Cas80, Cas82, Cha89, Che83, Chr89, Coh81, Coh82, Col87, Col88b, Col88a, Cor81, Cor87, Cre87, Cro80, Cro88a, Cru82, Cru84, Czi89, Dal87, DeG81, DeP88b, DeP88a, Dea81, Dea82, Dea89, Deh87a, Der88, Der89, Dic89, Dic82, Dow88, Dri89, Dud82, Dun89, Eas80b, Eas80a, Eas85, Edd87]. **Book** [Ell82, Ens80, Far88a, Far88b, Fed80c, Fed80d, Fed80a, Fed80b, Fed81h, Fed81j, Fed81g, Fed81f, Fed81d, Fed81k, Fed81c, Fed81i, Fed81b, Fed81l, Fed81e, Fed81a, Fed82b, Fed82a, Fed82c, Fed84e, Fed84a, Fed84d, Fed84b, Fed84c, Fre88, Ful89, Gar85, Gau88, Gbu81, Gbu83, Gho88, Gib83, Gib88, Gle84, Gok81, Gok83, Gol88, Goo87, Goo88, Gos86, Gra87a, Gra87b, Gri89, Gri88, Gro89, Gru88b, Gru88a, Gun87, Gun88a, Gun83, Gun84, Gun85a, Gun85b, Gun85c, Gup82, Gup83, Gup89, Hac80, Hah81, Hah82, Han89, Han84a, Han85b, Han85a, Han84b, Han84c, Han86, Han88, Har89a, Har89b, Har86, Har87, Har83, Har80, Has88, Hau87, Hau89, Hea89, Hea82, Hei80b, Hei80a, Hel87, Her89, Hid86, Hin87, Hix87, Hod87, Hod89, Hor86, Hor82,

Hsi87, Hub89, Igl88, Ima86, Ing81, Iye87]. **Book**
[Ize87, Ize88, Ize89, J.80d, J.80a, J.80b, J.80e, J.80c, Jac80b, Jac80a, Jac80d, Jac80c, Jac81, Jac84, Jac85f, Jac85d, Jac85c, Jac85e, Jac85b, Jac85a, Jac86b, Jac86a, Jac89, Job89, Joh87, Joh89, Joh82, Joh83, Jol88, Jon88, Jon89a, Jon89b, Kad84, Kal83, Kan87b, Kan87a, Kat82, Ker85, Khu87, Kim82, Kin87, Kle82, Klo82, Koc81, Kot88, Lac81, Lac82, Lak87, Lak88, Lam84c, Lam84b, Lam84a, Lan87, Lan88, Lar89, Law86c, Lee81, Lee82, Lee83, Lee89a, Lee89b, Lee89c, Lew87, Lin81b, Lin81a, Lin84, Lit88, Lit89, Liu89, Loc87, Low82, Low83a, Low83b, Luc81, Mac81, Mac83, Mar88a, Mar88b, Mar83, Mas88, Mat80, Maz87, Maz88, Maz89, McC87, McC85, MM83b, McL88, McL89, Mee87a, Mee82, Mee85, Mee86, MM82b, Mey88, Mie82, Mil81, Min86, Min87]. **Book**
[Min88, Min89, Moe83, Mor84, Mor88a, Mor88b, Mul83, Mul89, Mye80, Nac89, Nac87a, Nac87b, Nai88a, Nel81, Nyc89, Obr81, Obr82b, Obr82a, Odo80, Owe88, Owe89, Par89, Par88c, Par82, Par83, Pen81, Per89, Per82, Per84, Per88, Pie88a, Pie89, Pie90, Pig88, Pil83b, Pil83a, Pla88, Por82a, Por82b, Pre83b, Pri81, Pri85, Pro87a, Pro87b, Pro87c, Pro87d, Pro88b, Pro88a, Pro89a, Pro89b, Pro89c, Pry89, Que88, Rab89, Ran82, Ran86, Ran87, Rao80, Rea89, Ree81, Ree88, Rel82, Rey88, Rig88, Rig89, Roc87a, Roc87b, Roh80, Roh81, Roh82, Roh83a, Roh83b, Rup87, Rus88, Sal86, Sal89, Sar89, Sav83, Sch88, Sch81a, Sch83b, Sch83a, Sch82, Sch89a, Sch81b, Sch84g, Sch84e, Sch84b, Sch84a, Sch84f, Sch84d, Sch84c, Sch85d, Sch85e, Sch85b, Sch85f, Sch85g]. **Book** [Sch85c, Sch85a, Sch86c, Sch86b, Sch86a, Sch87a, Sch87b, Sch89d, Sch89c, Scl81a, Scl81b, Sei82, Sen80, Sen89, Set84, Sha82, Sha84, She88, She81a, She81b, She87, She89, Shu87, Sid80, Sid82, Sid84, Sin80, Sin81, Sin82, Sin87, Ski83, SG80, Smi87, Smi88, Spr83, Sta88, Ste89a, Ste89b, Sto80, Swa81a, Swa80, Syl81, Syl87, Syl88, Sys82, Tay83, Ter89, Thi88, Tho86, Tho88, Tho89, Tuc82, Tuc84, Tup89, Tur89, Vin89, Voe89, Wal89, War87a, War87b, War88, Was89, Wat82, Wat84, Web83, Wei87, Wei90, Wel89, Win87, Woo86, Yan89, Yfa87, You80, Zah89, Zai80, Zai87, Zie85a, Zie86c, Zie86a, Zie86b, Zie87c, Zie87b, Zie87e, Zie87h, Zie87g, Zie87f, Zie87d, Zie87a, Zie88e, Zie88b, Zie88i, Zie88k, Zie88o, Zie88l, Zie88y, Zie88m, Zie88p]. **Book**
[Zie88t, Zie88v, Zie88n, Zie88s, Zie88u, Zie88x, Zie88r, Zie88q, Zie88z, Zie88w, Zie88-27, Zie88f, Zie88d, Zie88a, Zie88j, Zie88c, Zie88g, Zie88h, Zie89d, Zie89h, Zie89i, Zie89b, Zie89c, Zie89q, Zie89u, Zie89p, Zie89r, Zie89s, Zie89e, Zie89a, Zie89f, Zie89w, Zie89m, Zie89k, Zie89l, Zie89x, Zie89v, Zie89n, Zie89o, Zie89t, Zie89g, Zie89j, vT88]. **Bootstrap** [BB89, Rob83]. **Borg** [Jac81]. **Bos** [Zie88z]. **Both** [GC82]. **bound** [Wel82]. **Bounded** [BS81, Oma83]. **Bounds** [JSOS85, MB88, Wal86, Sax81]. **Bowen** [Sin81]. **Bowerman** [Hau89, Joh87]. **Box** [Fre88, Boa85a, Boa85a]. **Bozdogan** [Zie89l]. **Bradley** [Klo82, Low83b]. **Branch** [Wel82]. **Branch-and-bound** [Wel82]. **Branching** [Sys82]. **Break** [EJG84]. **Breakdown** [Ham85]. **Brelsford** [Ell82]. **Brian**
[Boo88, Lac81, Zie87d]. **Brillinger** [Aro85b, Boa85b]. **Brockwell** [Dic89]. **Broechaert** [Zai87]. **Brook** [Dal87, Nac87a]. **Brookes** [Scl81a]. **Brown**

[Klo82, Gun87, Hea82]. **Bruce** [Hau89, Joh87, Pig88, Sin81]. **Brunner** [Jac80d]. **Bruno** [Joh82, Sch85c, Swa81a]. **Brushing** [BC87]. **Building** [Fre88, HJ86, Gra87a]. **Bulk** [Bil88a, Bil88b]. **Bunke** [Zie88g, Zie88g]. **Bunn** [Har86]. **Burman** [Zie87b]. **Burr** [CJ86]. **Bury** [Rig88]. **Business** [Sal89, Sch84d]. **Butler** [Lee89a]. **Byrkit** [Zie89u]. **Byron** [Klo82].

**C** [Ber89b, Boa85a, Bre89, Cas80, Dal87, Dow88, Fed81b, Gbu81, Gib83, Gos86, Gun85b, Han84a, Has88, Jac81, Jon88, Koc81, Lee83, Mas88, McL89, Mey88, Mil81, Moe83, Nac89, Nac87a, Nyc89, Per89, Pri81, Pro87d, Que88, Roh83b, Sal89, Sar89, Sch81b, Scl81a, Sen80, Shu87, Syl81, Sys82, Tho86, Tho88, Wei87, Zah89, Zie86a, Zie88e, Zie88y]. **Cady** [MM83b]. **Calculating** [Pie83a]. **Calculus** [Zie89j]. **Calibration** [Ano90b, Buo86, CSS88, Eas81, GS82, Hil81, HL81b, HL81a, KSSY84, Law81, LRS82, Lwi81, LM82, MD80, Næs85, Oma84, Orb81, RS81, SS89, SB89, VIC89, HL84, LM85]. **Calibration-Curve** [CSS88]. **Call** [PS87]. **Call-Record** [PS87]. **Calvin** [Car87a]. **Campbell** [Aro83, Bow83]. **Canada** [Fed84d]. **Capability** [GJM89]. **Carbone** [Aro85c]. **Carl** [Hel87, Rao80]. **Carl-Erik** [Rao80]. **Carlo** [Ang88, Sei82, Was89, BM87a, SM84]. **Carlsson** [Han84a]. **Carroll** [Wei90, Ano90c]. **Carson** [Mor84]. **Carter** [Sch84a]. **Carvalho** [Abr81]. **Case** [RG86]. **Casebook** [Klo82]. **Casella** [Zie88y]. **Cases** [CW80, CW83, HW88, Wei81]. **Cassel** [Rao80]. **Castelle** [Gra87a]. **Casti** [Czi89]. **Catalytic** [HMW80]. **Categorical** [Agr86a, Agr86b, Agr88, Bis83, BJ86, BR85, Gok83, McC85, McC86, Nai86a, Nai86b, Tit80b, Wu81]. **Categories** [Jac86a]. **Caulcott** [Zie88i]. **Causal** [Nyc89]. **Cause** [Atw86]. **Celebration** [Zie86a]. **Cell** [Bai80b]. **Cells** [Ano90a, Sim88a]. **Censored** [Ait81, BS83, HMS81, Hsi86, Koz80, Mor88a, Nai84, OS88, San85, SGN85, Sch89b, SH83, Sin83, Sin92]. **Censoring** [Mee84b, Pie87, Rob83, Kim82]. **Censues** [Por82a]. **Center** [Dra82]. **Central** [Ald81]. **Centroids** [Pie83a]. **Chain** [BA89, Car87a, Kat81, Woo84]. **Chalmer** [Pig88]. **Chambers** [Woo86]. **Chance** [Sha82]. **Change** [GM86, Hen86, Lom86, Lom88]. **Change-Point** [Hen86, Lom86]. **Changing** [CB80, VIC89]. **Characteristic** [She81b]. **Characteristics** [Lor80]. **Characterizations** [CW80]. **Charles** [Fed81i, Joh82, Kad84]. **Chart** [BLSF88, San89]. **Charts** [Ano85e, BR88, CW87a, Cro87, LV86, RAAN88, Roc89, San89, WLP85, WLV86, BR89]. **Chase** [Gun87]. **Chatfield** [Lee83, Mil81]. **Chatterjee** [Maz89]. **Check** [SKC83]. **Chemical** [Bac80, MW80b, MW80a, TM85, Yfa87, Zai87, Zie89o]. **Chemistry** [Scl81a]. **Chemists** [Zie88e, Zie89m]. **Chemometric** [Agr89]. **Cheremisinoff** [Cro88a, Pro89a]. **Chiang** [McC87]. **Chien** [Sin82]. **Chien-Pai** [Sin82]. **Chin** [Maz88, McC87]. **Chin-Kuei** [Maz88]. **Cho** [Maz88]. **Choice** [EK82, GZ79]. **Cholesky** [HE82]. **Chomet** [Roh83a]. **Chosen** [CR80]. **Chris** [Boy80]. **Christensen** [Bor87, Smi87]. **Chronological** [Sch85g]. **Circuit** [Mee87b]. **Circular** [Wat82]. **Civil** [Lee89b]. **Claes** [Rao80]. **Claes-Magnus** [Rao80]. **Claire** [Jon89b]. **Clark** [Sch89d, Edd87, Jac85b, Zie88c]. **Clarke** [Sto80]. **Class**

[LLS80, NA88, Par87]. **Classical** [Bru86, Hur86, Cor87]. **Classification** [BG84, CW87b, Fed84b, JG80, Lin81a, SK84, SK85, Gra87b, Lac82]. **Classifications** [J.80d]. **Classified** [J.80a, Jac86a]. **Classifiers** [GS82]. **Cleveland** [Col87, Zie89v]. **Clinical** [Ker85]. **Cluster** [Lin81b, Zem86, Lac81, Lin81a]. **Clustering** [All84, GL84a, GL84b, HLG85, Hoc84, Wei84, Lan87]. **Clyde** [Asc89]. **Cochran** [Cor81, Sav83]. **Code** [Mul83]. **Coefficient** [New80, dVS89]. **Cohen** [Mar83, Mul89]. **Coles** [Syl81]. **Colin** [Zie89d]. **Collected** [Boa85b, Boa85a, Zie88-27, Zie88-28, Zie89v]. **Collection** [Han84a, Sch87a, Zie87a]. **Collinearities** [MG85]. **Collinearity** [Par81]. **Collins** [Lee83]. **Colloquia** [Fed82b]. **Colombo** [Lee89c]. **Combinations** [BG84]. **Combinatorial** [Ber89a, Fed81a]. **Combined** [Ham85, Miy82]. **Combining** [HR88]. **Comment** [Atk84, Bec84, Cop83, Cor84, Cox84, Hah84b, Joi84, Pik84, SH84a, SH84b, Zie84]. **Common** [Atw86, SB83, SS81, YSOE84]. **Compact** [Cas80]. **Comparative** [Ano84e, CJJ81, Mee82, Nai84, Tit80b, Har86]. **Compare** [SC82]. **Comparing** [BT81, BT83, Hsi86, Lee80a, Tor89]. **Comparison** [Atk81, Bjø80, Bru86, Cam83, CN80, DG87, Khu86, Lit89, Mee84b, SM84, WTA80]. **Comparisons** [BD82a, HM84, Chr89]. **Competing** [Eas80b]. **Complete** [BS83, MTL82]. **Complex** [Hah84a]. **Component** [EK82, Goo88, HGB89, Maz80, Miy82, Pie82]. **Components** [Bre89, BG84, Cha87, EK82, Fel86, GC82, HJ86, JG80, MWF88, Swa81b, SM84, Sax81]. **Composite** [Dra85, ETM80, Rub80]. **Compositional** [Pie88a]. **Compound** [LM82, MLG82, LM85]. **Comprehensive** [Zie89u]. **Compstat** [Zie88n]. **Computation** [MG84, Ste89a]. **Computational** [DS87, Sch82, Zie88n]. **Computer** [CN89, Cru82, Der89, Fed81j, GK80a, Hau89, Hea82, Hod89, J.80e, Luc81, Mul83, SSW89, Wel84, Zie88v, Zie89x, DeP88a, Fed82a, Jac85b, Zie89c]. **Computer-Aided** [CN89, Wel84, Jac85b]. **Computers** [Cas80, Han84b, Zie89q]. **Computing** [Edd87, Ell82, Har89a, Kao88, Ste89a, Rel82, Zie87d, Gun85a]. **Concentration** [SMV82]. **Concentrations** [SAJ89, Ven82]. **Concepts** [Ber82c, Gro89, Hau89, Pro87a, Pro88a]. **Conceptual** [She87]. **Conditioning** [BH84]. **Conference** [Aro84a, Fed80c, Fed81d, Fed81k, Fed84e, Par83, Zie89n, Fed81i]. **Confidence** [Bai80b, BE81, BA89, BG84, CCMC86, CI83, Che87, CI88, Cro82, Dal83, DS87, DL87, GJBR88, JT83, JG80, MD80, McD81, Nai84, Pie86, Rob83, San85, Sch84c, SGN85, Sch87b, ST86, Spu81]. **Conflict** [DeG81]. **Confounded** [Fra85]. **Confounding** [Col89]. **Conolly** [Che83]. **Conover** [Obr81]. **Consequences** [MK84]. **Considerations** [Buo86]. **Consistent** [Pie83b]. **Consonance** [Sal80]. **Constance** [Aro84b]. **Constant** [Hjo80]. **Constantin** [Har89a]. **Constituents** [SMV82]. **Constrained** [Cro86a, Pie82, Pie83a]. **Constraint** [Pie83b]. **Constructing** [CN80, FMM80, Fra84, JN83, PG86]. **Construction**

[DA88, Hai87a, NG85, Wu81]. **Consultant** [Zie89w]. **Consulting** [Gun84]. **Contagious** [Kat82]. **Contemporaneously** [DP81]. **Contemporary** [Sch88]. **Content** [Mee84a]. **Continental** [Ano84e, CJJ81]. **Contingency** [Ano90a, Odo80, Sim88a]. **Continuous** [Car87a, CLS86, CI83, Haw80, She81a, Sys82, Woo83, Yan83]. **Contrasts** [BD82a, Fra85]. **Contributions** [Sav83]. **Control** [AW89, Ano85e, Bac80, BR88, BH80, BT81, BT83, BLSF88, Ber87, Bry89, CW87a, Cro86b, Cro88b, DPM80, Fed81b, Gun83, HMW80, HM84, Hsi87, Koc81, Liu89, Loc87, LV86, LC82, MW80b, MW80a, MHW84, Pie90, Roc89, San89, Syl87, Vin89, Wal86, WLP85, WN85, WLV86, Zie88x, BR89, Cro89, Fed84a, Maz88, Per82, Per84, Per88, Pro87d, Que88, Sta88, Tuc84, Voe89, Woo86, Zie88f]. **Control-Chart** [San89]. **Control-Test** [HM84]. **Controllers** [HMW80]. **Controversies** [Pro87a]. **Controversy** [LM82, LM85]. **Convergence** [BW81]. **Convex** [JN83]. **Cook** [Lin84]. **Cooke** [Edd87, Sto80]. **Cooley** [Zie88k]. **Coomans** [Zai87]. **Coombs** [Asc89]. **Coordinate** [Han89]. **Coordinate-Free** [Han89]. **Cornell** [Dic82, Joh89, Pro87c, Zie87h]. **Cornwell** [Spr83]. **Corrected** [Gan81]. **Correction** [Ano86e, Ano90a, Ano90b, BR89, BT98, BM87b, Cro89, IC89, LM85, McL80, NP89, Sin92, Ste90, YB87]. **Corrections** [Ano85e, Ano90c, DM88, WB88a]. **Correlated** [DP81, Hen86, Khu86, OL81, Tan87, WMS85]. **Correlation** [EJG84, HE82, IC87, IC89, Tuc82]. **Corrigenda** [Ano80e, Ano80f, Ano81e, Ano82e, Ano82f, FHL81, Kit81]. **Corrigendum** [Ano80g, Ano83e, Ano84e, Ano84f, EL83, HL84]. **Cost** [Gau88]. **Counted** [Luc85]. **Counterexamples** [EL81, EL83, Zie88o]. **Counting** [Nel83, Far88a]. **Course** [Far88b, Goo87, MM82b, Roh83a, Sto80, Zie88k, Hix87]. **Covariance** [HE82, Low83b, Næs85, War87b]. **covariates** [Wu81]. **Cox** [Boe83, BJ81, Col88a, Has88]. **Coxon** [Jac85f, Jac85d]. **Craven** [Edd87]. **Credal** [Sha82]. **Crew** [Fed82a]. **Critchlow** [Sin87]. **Criteria** [Atk81, Box88a, Box88b, CR88, Gun88b, Han84a, Kat81, NP88a, Par88b, STL88, Ull88, Wel82]. **Criterion** [BW81, Bro89, HH81, HW85, NW79, You82]. **Criticisms** [EL81, EL83]. **Crocker** [Pro87d]. **Crop** [Chh86]. **Cross** [EK82, J.80d, Jac86a, JG80]. **Cross-Classification** [JG80]. **Cross-Classified** [Jac86a]. **Cross-Validatory** [EK82]. **Crossings** [Ked87]. **Crow** [Job89]. **Cryer** [Bow87]. **Csörgö** [Fed84d]. **CSP** [Car87a, She81a]. **Cubic** [Dra83a]. **Cugiani** [Fed81h]. **Cumulative** [CI83, CI88, Cro86b, Cro88b, HH81, Yas89, Cro89]. **Cureton** [Jac85c]. **Current** [BE80]. **Curtailed** [Ano85e, WLP85]. **Curve** [CSS88, DV86, MD80, She81b]. **Curves** [CLS86, Nel85, VIC89]. **CUSUM** [Hea87, LC82, Luc85, VoR85, Wal86, Woo83, Woo84, WN85]. **Cut** [DV85]. **Cuthbert** [Luc81]. **Cyclic** [Mor88b].

**D** [Abr81, Aro84a, Aro84c, Aro84d, Aro85b, Aro86b, Aro86a, Ber83, Boe83, Boo88, Bow87, Bul89, Car88, Coh82, Col88a, Dea82, Eas80a, Edd87, Fed80c, Fed80d, Fed81d, Fed81l, Fed84e, Fed84d, Gho88, Gup89, Hac80, Hah81,

Har86, Har87, Hei80b, Hsi80, J.80b, J.80c, Jac80c, Jac85c, Kim82, Kle82, Lac82, Lee89a, Mee87a, Mee86, Nel81, Odo80, Par83, Roh83a, Sch81b, Sch84c, Sch87a, Sin80, Sin81, Sto80, Ter89, Wal89, Web83, Wei90, Woo86, Zai80, Zai87, Zie87e, Zie87a, Zie89p, Zie89e, Zie89a, Zie89w]. **Dacunha** [Gra87a]. **Dacunha-Castelle** [Gra87a]. **Dagnelie** [Pil83b, Pil83a]. **D'Agostino** [Kin87]. **Dallas** [Sch85a]. **Dan** [Fed81i, Har89a]. **Daniel** [Agr88, Ell82, Kad84, Koc81, Luc81, She81b, Win87, Hei80b, Pen81, Zie88m]. **Data** [Agr86a, Agr86b, Agr88, Ait81, Ano84e, BJ87, Ber84, Ber89a, BJ86, BR85, Chh86, CJJ81, CJ86, Cre87, Deh87a, Fed81k, GM86, Gok83, GC85, Gri89, GH80, HMS81, Hai87b, HBK84, Hoe87, Hsi86, Hur86, Jac80d, Jac85e, Jac85a, Jac86a, Kad84, Koz80, Lak87, Lan87, Lee80c, Len81b, Lin81a, Lom86, Luc81, Luc85, Mac81, McC86, MM83b, Mea89, Miy82, Moe83, Mor87, Nai84, Nai86a, Nai86b, Par88c, Pro87b, Pry89, Rab89, Rig89, San85, Sch85a, Sch89c, SH83, She89, SW86, Shu87, SAJ89, Sid82, Sin81, SG80, SS81, Suz85, TM85, Tho86, Tit80b, Tup89, ZG80, Zie88k, Zie88-27, Zie89d, Zie89r, Zie89l, Zie89x, dLNB$^+$81, Bin89, Bis83, Col87, Cre87, Dic82, Gar85, Gho88, Hac80, Hin87, Ing81, Iye87, Jac81, Kan87b, Kle82, Kot88, Lac82, Luc81]. **Data** [McC85, Pie88a, Ree88, Roc87a, Sch83b, Sch86c, Sin87, Ste89b, Tur89, You80, Zie89s, Bor87, Sch87a, Zie87a]. **Data-Dependent** [Hur86]. **Data-Oriented** [Mac81]. **Davenport** [Hea89, Khu87]. **David** [Boa85b, Dow88, Jac89, Joh87, MM83b, Pro87a, Pro88a, Sch84g, Sch87b, Sid84, Tho86, Wat84, Zie89c, Chr89, Mac83]. **Davies** [Jac85d]. **Davis** [Ano80e, Dic89, Shu87, Tuc84]. **Dawson** [Fed84d]. **Dean** [Bea83, Dun89, Fed81l]. **DeAntoni** [Zie88n]. **Decade** [Lam84b]. **Decision** [Ber82c, Cal88, Dud82, Han84a, Han85b, Zai87]. **Decisions** [Har87]. **Deconvolution** [SD85]. **Decreasing** [DV86, FG88, Hjo80]. **deFinetti** [Swa81a]. **Defining** [Fra85, Pie83b]. **DeGroot** [Ber83, Zie87f]. **Dehnad** [Pie90]. **DeMaio** [Low82]. **Deming** [Agr89]. **Dennis** [Gri88, Lam84c, Lin84, Mee87a, Pro88a]. **Density** [DV86, Tit80b, Deh87a]. **Departures** [MK84]. **Dependent** [Hur86, SC82]. **Depends** [PC85]. **DePriest** [Sch84e, Mie82, Thi88]. **Derivative** [Bat83]. **Dertougos** [J.80e]. **Design** [Agr89, Ano85e, Atk81, Atk84, BR88, BT83, Bec84, Bis89, Buo86, Che87, Cor84, Cox84, Dea82, FTK89, Gup89, Hah84a, Hah84b, HW85, Han86, JN83, Joi84, Lee89b, LV86, Mor87, Pie90, Pik84, Sen89, SH84a, SH84b, Tan87, Tit80a, Wel84, WLP85, WLV86, Zem86, Zie84, Zie88y, BR89, Law86c, Nac87a, Caf87, Gun85b, Mey88, Zie89d]. **Designed** [Sch85a]. **Designing** [Par89]. **Designs** [AD83, BT81, BD82b, BM86b, CN80, CN82, CN89, Dic82, DA88, Dra82, Dra83a, Dra85, DS88, DJ88, Fed81a, Fra84, FH80, GK80a, GJM89, Hai87a, HM84, Hil80, Joh89, JN83, Khu84, Khu88, MM83c, NGG83, Par87, SSW89, San89, SM81, SS82, VDY81, Zie88e, BM87b, Wel82, Dea81, Ens80, Mor88b, Nac87b, Pro89c, Zie85a, Zie87b]. **Destructive** [EJG84, SY87]. **Detect** [Sim88b]. **Detecting** [Ano90a, Boo87, CW80, CP81, Lom88, Mar85, MM83c, Sim88a, Wan87]. **Detection** [AC89, All84, Dav79, GL84a, GL84b, HLG85, Hoc84, Jai81, Kit79,

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[Maz87]. **Down** [IC87, IC89]. **Downing** [EDGH86]. **Draper** [Hah82, Fre88]. **Driver** [Zie89q]. **Dual** [Gok83]. **Duality** [MHW84]. **Dublin** [Fed84e]. **Dudewicz** [Mul83, Zie89k]. **Dugger** [Hsi80]. **Duncan** [Zie88x]. **Dunn** [Zie88c, Jac85a, Mye80]. **Dynamic** [CWC+89, Tit80a, TB80]. **Dynamical** [Czi89]. **Dynamics** [Ang89].

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**F** [Asc89, Ber83, Che83, Cro80, Fed81j, Gup82, Han85a, Igl88, Jac86b, Kad84, Mac81, McL88, Ree81, Rup87, Sch83b, Sch83a, Sch85d, Sch87a, Sch89c, Sid84, Sin80, Sin81, Zie87a, Zie88n, Zie89s, Zie89t]. **Faà** [Sch85c]. **Faces** [Sha84]. **Factor** [Jac89, JG80, MS82, dLNB$^+$81, Jac85c]. **Factorial** [CN89, Fra85, HMS81, Nac87b, NP88b, Ste88, Zie85a, NP89]. **Factorials** [AD83, BM86a, Che89, GND82, Len89]. **Factorization** [HE82]. **Factors** [MM82a, McD81]. **Failure** [ASVR85, Atw86, Hjo80, Kle82, MDH80, Mee87b, Miy82, Sch89b]. **Failure-Censored** [Sch89b]. **Failure-Free** [ASVR85]. **Failures** [MB88].

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**G** [Ams87, Ang89, Box87, Bro89, Bul89, Caf87, Cor81, Cro80, Edd87, Fre88, Gro89, Gun88a, Han85a, Har80, Hsi80, Jac80c, Jac85a, Jac86b, Joh82, Klo82, Lee89c, Liu89, Mul83, Per82, Per84, Roh83b, Sav83, Scl81a, Sto80, Syl81, Tuc82, Zie88y, Zie89g]. **Gabriel** [Ano80e]. **Gaines** [Han85b]. **Gale** [Zie89b].

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**H** [Agr88, Ber83, Chr89, Cor87, Dal87, Edd87, Far88b, Gau88, Gos86, Han85b, Hsi87, Ize89, J.80d, Jac80d, Lam84a, Lee89a, Lit88, Liu89, Loc87, Mac83, McL88, Mee85, MM82b, Mor88a, Nac89, Owe89, Par82, Per82, Sal89, Sch85f, Sch85g, Set84, Sin80, Smi88, Sys82, Tuc84, Was89, Zie87e, Zie88k, Zie88p, Zie88v, Zie88g, Zie89e, Zie89a, Zie89f, Zie89l, Zie89g, Zie89j]. **H.-J** [Han85b, Liu89]. **Hadamard** [NG85]. **Hadi** [Maz89]. **Hahn** [Kan87a]. **Hakan** [Rao80]. **Halmos** [Han89]. **Hamburg** [Sin80, Cal88]. **Hampel** [Rup87]. **Han** [Sin82]. **Hand** [Zie89w, Coh82]. **Handbook** [Has88, Mul83, Sch85b, Zie88b, Goo87, Pla88, She88, Aro83, Aro85b, Asc89,

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**L** [Abr81, Agr89, Bas86, Bis83, Bor86, Cha89, Czi89, Fed80d, Fed84b, Gol88, Gos86, Gru88a, Han85b, Han86, Har89b, Har83, Hau89, Hei80a, J.80e, Jac80b, Job89, Joh87, Jon89b, Kle82, Lar89, Loc87, Mac81, Mee87a, Moe83, Nac89, Ree88, Roc87b, Sch82, Sch81b, Sch84e, Sch84d, Sch85c, Sch86b, Sch89d, Sta88, Sys82, Vin89, Wal89, War87a, Yan89, Zie85a, Zie87g, Zie88q, Zie89d, Zie89m, Zie89g]. **Labor** [Lam84c]. **Laboratory** [Ize89]. **Lack** [BD82b, Dra83a, DG87, Khu85, SKC83]. **Lambda** [ÖD85]. **Lambert** [Sch88]. **Landwehr** [Hin87, Min89]. **Lane** [Dri89]. **Large** [Bai80b, Bin80, Boo84, Lan87, Nel83, Ste87, Ste90, WG79, Wil80, Gok81]. **Larry** [Spr83, Tup89]. **Larsen** [Bor86]. **Larson** [Par82]. **Latent** [WG79, Jac89, Sar89]. **Latin** [Ste90, Ste87]. **Launer** [Jac80b, Sch84e]. **Laurence** [She87]. **Lauro** [Zie88n]. **Laveen** [Nai88a]. **Law** [Zie87f]. **Lawless** [Sch83b]. **Lawrence** [Ber89a]. **Laycock** [Cop83]. **Layout** [GH80]. **Layouts** [GH81]. **Leach** [Boy80]. **Leamer** [Ing81]. **Learning** [HI87]. **Least** [BW81, DS87, GZ79, HMS81, ÖD85, Rub80, SMV82, DM87, DM88, Sch89a].

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**M** [Abr81, Ang89, Aro84a, Aro85c, Ber83, Bil84, Bro89, Dal87, DeP88b, Dea81, Edd87, Ell82, Fed84d, Gup83, Hau87, Hea82, Hid86, Hin87, Ize88, Jac85f, Jac85d, Jon89b, Khu87, Kin87, Lak87, Lee81, Lee82, MM83b, Mey88, Nel81, Owe88, Owe89, Par83, Pie89, Pre83b, Rey88, Roc87b, Roh80, Rup87, Sch89a, Sch84a, Sch87a, Scl81a, Sen80, She81b, Sin80, Sto80, Swa80, Syl87,

Sys82, Tho89, Tuc84, Vin89, Zah89, Zai80, Zie87f, Zie87a, Zie88t, Zie88u, Zie89i, Zie89p]. **Machines** [GS82]. **Madan** [Bas86]. **Madsen** [Sch84d]. **Magazine** [Lam84b]. **Magnus** [Rao80, Zie89j]. **Main** [Che89, GND82, NG85, PM89]. **Main-Effect** [Che89, GND82, NG85, PM89]. **Major** [Aro85c]. **Making** [Aro85d, Han84a, Cal88, Zai87, Har87]. **Makridakis** [Aro85c, Cha89, Pri81]. **Mallows** [BM88, Zie89d]. **Malvin** [Was89]. **Management** [Fed80d, Fed81b, Fed81l, Fed84c, Gbu81, Han85b, Mee85, Pri81, She88, Zai80, Asc89, Obr82b, Zie88r, Zie88q]. **Managers** [Bry89]. **Mandel** [Cor80]. **Mandl** [Fed80b]. **Manning** [Hix87]. **Manski** [Kad84]. **Manual** [She81b]. **Manufactured** [BHP84]. **Manufacturing** [Bry89, Gun85c]. **Many** [BT82, Jai81, Ros83, Sch87a, Zie87a]. **Many-Outlier** [Jai81, Ros83]. **Marasinghe** [FM87]. **March** [Fed80c, Fed81d, Fed84e]. **Marco** [Fed81h]. **Mardia** [Lee81]. **Margerison** [Hac80]. **Marginal** [YY87]. **Marie** [Fed80b]. **Marija** [Gib88, Par88c, vT88]. **Maritz** [Ski83]. **Mark** [Jol88]. **Market** [Lam84c]. **Markov** [BA89, Kat81, Woo84]. **Martz** [Sch83a]. **Marvin** [Jac86b]. **Marx** [Bor86]. **Mary** [McL89]. **Masanao** [Wel89]. **Mason** [Mac81]. **Material** [Hen86]. **Materials** [AL82, Bil84, Fer82, GPS82a, GPS82b, Jae82, LD82, Mog82, Moo82, Mor82, Ven82, Bil88b]. **Mathematica** [Fed82b]. **Mathematical** [DeG81, Hea89, Khu87, Lin81b, Ran82, Spr83, Zie88s, Zie89f, Zie89k, Fed81f, Mee87a, Rab89, Scl81b, Zie88t]. **Mathematics** [Che83, Eas80b, Fed81a, Low82, Scl81a, Zai80, Zie88v, Syl81]. **Mathews** [Zie88v]. **Matlock** [Zie89e]. **Matloff** [Hod89]. **Matrices** [GZ79, NG85, Sch85d, Zie89i]. **Matrix** [Cor80, HE82, Khu86, Næs85, Sch85e, Zie89j]. **Matter** [Ano80a, Ano80b, Ano80c, Ano80d, Ano80h, Ano80i, Ano80j, Ano80k, Ano81a, Ano81b, Ano81c, Ano81d, Ano81f, Ano81g, Ano81h, Ano81i, Ano82a, Ano82b, Ano82c, Ano82d, Ano82g, Ano82h, Ano82i, Ano82j, Ano83a, Ano83b, Ano83c, Ano83d, Ano83f, Ano83g, Ano83h, Ano83i, Ano84a, Ano84b, Ano84c, Ano84d, Ano84g, Ano84h, Ano84i, Ano84j, Ano85a, Ano85b, Ano85c, Ano85d, Ano85f, Ano85g, Ano85h, Ano85i, Ano86a, Ano86b, Ano86c, Ano86d, Ano86f, Ano86g, Ano86h, Ano86i, Ano87a, Ano87b, Ano87c, Ano87d, Ano87e, Ano87f, Ano87g, Ano87h, Ano88a, Ano88b, Ano88c, Ano88d, Ano88e, Ano88f, Ano88g, Ano88h, Ano89a, Ano89b, Ano89c, Ano89d, Ano89e, Ano89f, Ano89g, Ano89h]. **Matthes** [Cas82]. **Matthew** [Jac84, Low83a, Min88]. **Matusita** [Fed81k]. **Max** [Zie88s]. **Maximum** [BE81, CA81, EBW81, Hur86, Jon80, Lin81b, McL80, NW89, SGN85, Vec85, Ber89b]. **Maximum-Entropy** [Ber89b]. **May** [Ber83, Fed84d, Han84a]. **McClave** [Far88b, McL88, Zie89t]. **McCulloch** [Zie88y]. **McFadden** [Kad84]. **McLean** [Zie85a]. **McNeill** [Zie89a]. **Md** [Fed84d]. **Mean** [BSA81, BD84, Ham85, Kre87, PG86, SAJ89, SK84]. **Means** [Cor80, MH80, Nel85, Nel88, SBE88]. **Measure** [IC87, IC89, Khu88]. **Measured** [OL81]. **Measurement** [Sal86, Yfa87, Bow83, Dea89]. **Measurements** [Zie89o]. **Measures** [Agr86a, Boa87, BD82b, BF87, Deh87b, Eas87, Len81b, LSK87b, PR87, WB88a, WB88b, Wu87, LSK87a, J.80d].

**Measuring** [Pie82]. **Mecke** [Cas82]. **Medhi** [Tay83]. **Medical** [JT83, Ree81, Zai87]. **Meeker** [Kan87a, Spr83]. **Meeting** [Ber83]. **Meltzer** [Jac80d]. **Melvin** [Sch84d]. **Memoriam** [Box87]. **Mendel** [DeP88b]. **Mendenhall** [Der89, Mee87a, War87a, Syl88]. **Merks** [Bil88a]. **Mervyn** [Han89]. **Messina** [Bry89]. **Messy** [Sch85a]. **Method** [Chr89, Cro87, DZ88, DV85, EM82, HWW85, HJ86, PBT85, Spu81, dVS89, Pie90, Sei82]. **Méthodes** [Pil83b]. **Methodologies** [DGH85]. **Methodology** [Dud82, Fri83, Hoc83a, Hoc83b, Mit83, MKC89, Sne83, Wel83, Pro87c]. **Methods** [AL82, Ang89, Asc83, Bas86, Ber89a, Bir83, BB89, Cas80, Dav79, Eng83, Eva83, Fer82, GK80a, GCR86, GPS82a, GPS82b, HW86, Hel87, Hub89, Ima86, J.80a, Jac80a, Jac85a, Jac86b, Jae82, Lac82, Law83a, Law83b, LD82, Mee83, Min86, Mog82, Moo82, Mor82, Por82a, Pry89, Rea89, Sal89, Sch83b, Sch83c, Sch89d, ST85, Sin87, Syl87, Tho83, War88, Was89, Zai80, Zie87e, Zie88e, Zie88l, Zie88v, Zie89p, Zie89s, Ber82c, Cor81, Dic89, Gro89, Has88, Jac86b, Ran87, Sch88, Ski83, Wal89, Web83, Zie88t]. **Metivier** [Roh81]. **Metric** [Sin87]. **Michael** [J.80e, Lam84a]. **Michel** [Roh81]. **Microbial** [YSOE84]. **Microcomputer** [Gos86, Han84c, Zie89e]. **Microprocessors** [Han84c]. **Mijnheer** [Sys82]. **Mike** [Gra87b]. **Mikel** [Gar85, Zie87e]. **MIL** [JT83]. **MIL-STD** [JT83]. **Miller** [Ize88, Klo82, Ams87]. **Milliken** [Sch85a]. **Milton** [Lee89b]. **Minimax** [Bjø80, PR82]. **Minimization** [Cas80]. **Minimum** [DS88, Fra84, FH80, Lik82, NW77, NW79, NW85, Par88a, Swa81b]. **Minoru** [Goo87]. **MINQE** [CW87b]. **Mishra** [Zie89k]. **Missing** [Gho88, Jon80, Roc87a, SS81, dLNB$^+$81]. **Missingness** [Sim88b]. **Misused** [Igl88]. **Mitchell** [GK80a]. **MIVQUE** [SM84]. **MIVQUE's** [Swa81b]. **Mixed** [BNC87, EM82, MDH80]. **Mixed-Model** [BNC87]. **Mixing** [MLG82]. **Mixture** [AW80, Ber87, Coh82, Cro84, Cro86a, Dic82, GC82, GC85, Hoe87, NGG83, Pie82, Pie83a, Pie83b, PC85, Pie88b, VDY81, Zie87h]. **Mixture-Amount** [Pie88b]. **Mixtures** [Dic82, Sne81, SMV82]. **ML** [SM84]. **Model** [AW89, Atw86, Bac80, BNC87, BSA81, BJ81, CR87, Cha87, CB80, CN82, Fre88, GC82, Gra87a, HGB89, HJ86, Ked87, Ket83, Khu85, MW80b, MW80a, MJ81, Mee84a, NW89, RPL81, Ven82, WTA80, YY87, YB87, Lak88, Lit88]. **Model-Based** [HGB89]. **Model-Building** [HJ86]. **Modeling** [AC89, BT82, DP81, FS89a, FS89b, Gbu83, Has89, Haw89, Hod89, PD80b, Swa80, Tor89, Wat84, Wel89, Smi87]. **Modelling** [Jon88, Lee89c, ZG80, Zie89l, And86, DeP88a, Jac85a]. **Models** [AW80, Atk81, BR88, BT89, Ber87, Che85, CP81, DeG81, Dic82, DGH85, Ens80, Gla82, Gup82, GJBR88, Hai87a, Hai87b, HW85, Har86, Hil80, Jac89, JG80, Joh87, Jon80, JSOS85, Khu84, Khu86, Lee80b, MS89, Min86, Moe83, NGG83, Par82, PD80a, PC85, Pie88b, Rig88, Rob83, Sch83b, ST85, SKC83, Ski80, Sne81, Tsa88, Tur89, Vec85, Wan85, Wan87, YSOE84, BR89, BT98, Bas86, Bat88, Ber82b, Dea89, Lam84a, Mar88a, Sar89, Zie86c, Zie88z, Zie88g]. **Modern** [Cor87, Tup89, Goo87, Owe88, Owe89, Smi88, Syl87, Zie89k].

**Modes** [CLS86]. **Modification** [DZ88, Mie82]. **Modified** [WW89]. **Moeschberger** [Sch84d]. **Moeschlin** [J.80c]. **Mohamed** [Han84c]. **Moment** [New80]. **Moments** [HWW85]. **Monitoring** [WW89, War88]. **Monotone** [BJ81, FT84]. **Monte** [Sei82, BM87a, SM84, Ang88, Was89]. **Montgomery** [Gib83, Gbu81, Gun85b, Que88]. **Moore** [Pro87a]. **Morgan** [Agr89]. **Morris** [Bor86, Cal88]. **Mortimer** [Lam84b]. **Moscow** [Han84a]. **Moses** [J.80e, Klo82, Pro88b]. **Most** [AB85, Gen80]. **Mosteller** [Tho86]. **MOSUM** [BH80]. **Motor** [GH80, Lee80c]. **Mottley** [Loc87]. **Moving** [Cro87, Vec85]. **MR** [EL83, FHL81, Hsi80, Kit81]. **MR0667653** [LM85]. **MR0697694** [HL84]. **MR0702171** [Sin92]. **MR0887702** [Ste90]. **MR0970999** [BR89]. **MR1007294** [BT98]. **Mrudulla** [Har89b]. **Much** [JO86]. **Muirhead** [Gle84]. **Mukherjee** [Gup83]. **Mullen** [Koc81, She81b]. **Muller** [Wal89]. **Multicriteria** [Han84a]. **Multidimensional** [Jac85f, Jac85d]. **Multifactor** [Luc81, MM83c, Par87]. **Multinomial** [Bai80b]. **Multiparameter** [Ber82a]. **Multiple** [BD82a, BH82, CSS88, Han84a, HE82, HBK84, JO86, KC81, MRR80, New82, Oma82, RHM87, SW86, SD85, SY87, Wor83, Dud82, Lit89, War87b]. **Multiple-Regression** [HBK84]. **Multiple-Use** [CSS88]. **Multiplicative** [MJ81]. **Multiresponse** [BW85a, BW85b, Khu85, McL85, SS81, YSOE84, Yan85, ZG80, Zie85b]. **Multistage** [JT83, MF83, Mar85]. **Multivariable** [Wal89]. **Multivariate** [Bac80, Bea83, Cro88b, Dun89, Fed80a, Gle84, Goo87, Gup82, Gup83, Han89, Haw81, Hea87, Hin80, Jac85b, Lac82, Lee83, MW80b, MW80a, Næs85, Sch84b, Sch84a, Sch84f, Sch86a, SB89, WN85, Zie87b, Jac86b, Zie88k, Fed80a, Fed81g, Jac85e, Jac86b, Jol88, Lee81, Lee82, Sch89c, Smi87, Zie86b, Zie89l]. **Murph** [Sin80]. **Murtagh** [Sch89c]. **Musgrave** [Sch82]. **MVUE** [Lik80]. **Myers** [Cor87].

**N** [Agr89, Bin89, Cro88a, Fed84d, Fed84b, Fed84c, Fre88, Gup83, Han84b, Hea89, Jac80b, Mey88, Nai88a, Roc87b, Ste89b, Zie87c, Zie87b, Zie88n]. **Nalimov** [Sha84]. **Narula** [Ano80f]. **Nash** [McL89, Cas80]. **nearly** [Wu81]. **Necessary** [RDR82]. **Neelamkavil** [DeP88a]. **Negoita** [Har89a]. **Neil** [Col88a, Low83a, Min88]. **Nelson** [Kan87b, Pro87b]. **Nerlove** [Abr81]. **Nested** [BSA81]. **Neter** [Lam84a]. **Network** [PS87]. **Networks** [TM85, Ang88, Coh81]. **Neudecker** [Zie89j]. **Neumann** [BN81]. **Never** [WTA80]. **Newbold** [Zie88z]. **Newby** [Ano82f]. **Newell** [Han85a]. **Newman** [Jon89b]. **Newton** [Aro85c, Ize89]. **Neyman** [Aro84b]. **Nicholas** [Pro89a]. **Nick** [Dri89]. **Nielsen** [Mat80]. **Nine** [Gun85c]. **Nishisato** [Gok83]. **no** [BR89, BT98, BM87b, Cro89, DM88, EL83, FHL81, HL84, IC89, Kit81, LM85, NP89, Sin92, Ste90, WB88a]. **Nobuyuki** [Kal83]. **Noise** [Box88a, Box88b, CR88, Gun88b, NP88a, Par88b, STL88, Ull88, LSK87a]. **Non** [Che83, J.80a]. **Non-Parametric** [J.80a]. **Non-Physical** [Che83]. **Nonexperimental** [Ing81]. **Nonlinear** [BW81, BS88, DS87, FTK89, FHL80, HW85, Hil80, Khu84, ST85, ST86, Tsa88, FHL81, Bat88, McL89, Wat84].

**Nonlinearity** [Wan87]. **Nonparametric**
[Ano80g, Boy80, GM86, KSSY84, Lee80c, Lom86, McD79, Obr81, Ran87, San85, Yan89, Zie89p, Bas86, Ima86, Ran86, Zie88d]. **Nonparametrics** [Joh83]. **Nonrandom** [Sim88b]. **Nonstationary** [Cle80, Hor80a, Hor80b]. **Norbert** [Loc87]. **Norma** [Bow83]. **Normal**
[Aro83, BS81, CO86, FF89, Hah81, HZ80, LNN61, Mee89a, MH80, Mor88a, RG86, SGN85, DM87, DM88, OCO89]. **Normality** [Col88b, Haw81]. **Normally** [Spr83]. **Norman**
[Dri89, Hah82, Har83, Hod89, Moe83, Sch85c, Sch86b]. **Norusis**
[Gib88, Par88c, vT88]. **Note** [Ait81, Far85, GC82, GC85, Haw80, Hea87, Khu84, Lik82, McL80, PG86, Pie88b, PM89, SD80]. **Nottingham**
[Fed80c, Fed81d]. **np** [Ano85e, WLP85]. **np-Control** [Ano85e, WLP85]. **Nuclear**
[AL82, Fer82, GPS82a, GPS82b, Jae82, LD82, Mog82, Moo82, Mor82]. **Null** [Ski80]. **Number** [EK82, MB88, Mul83, Nel83]. **Numbers** [Igl88]. **Numerical** [Cas80, Sch85f, ST85, Ste89a, Fed81h, Hel87, Zie87d, Zie88v].

**O** [Aro84a, Aro84c, Aro84d, Aro86b, Aro86a, Ber82c, Fed80c, Fed81d, Fed84e, J.80b, J.80c, Par82, Par83, War88, Zie88c, Zie88g]. **Oakland** [Per88]. **Objects** [Lin81a]. **Obremski** [Jon89b]. **Observation** [WP88]. **Observations** [BT83, DJ81, Gra87a, GK80b, Hen86, Jon80, Par88a, SS81, SB89, VoR85, DM87, DM88, Jac86b]. **occasions** [DM87, DM88]. **Occurring** [MHW84]. **O'Connell** [Joh87, Hau89]. **Odeh**
[Hah81, Hea89, Khu87, Sch84c, Lin81b]. **Offset** [BW81]. **O'Keeffe** [Zie88h]. **Olaf** [Ens80]. **Ole** [Mat80]. **Olive** [Mye80]. **Oliveira** [Che83]. **Oliveira-Pinto** [Che83]. **On-Line** [AW89]. **One** [BG84, Cha87, CI88, CO86, CW87b, DM87, DM88, Koz80, Mee84a, MB88, San85, Tan87, Wal86, Woo83]. **One-Sided** [CI88, CO86, MB88, San85, Tan87, Wal86, Woo83, DM87, DM88]. **One-Way** [BG84, Cha87, CW87b, Mee84a]. **Operating** [She81b]. **Operations** [Mee85, Fed81i, Zie88w]. **Optimal**
[BT83, CN80, CN82, Ens80, Fed81a, Hai87a, HM84, Hil80, JN83, Khu84, PS87, Par81, Tit80a, VDY81, Dea82, Sta88]. **Optimality** [Sen80, Wel82]. **Optimally** [CR80]. **Optimization**
[Ang88, BJS86, Hub89, KC81, Lak87, Zie88e, Bis81, Der88, Mee85]. **Optimizing** [Jac80a]. **Optimum** [DA88, GK80a, Maz80]. **ORAGWA** [Fed81i]. **Ord** [Aro86b, Zie89h]. **Order**
[Dra82, Dra83a, Kat81, Ked87, KE80, PD80a, Sch85g, SS82, VDY81, Mac83]. **Ordered** [Agr86a, Agr86b, BJ86, Jac86a, McC86, Nai86a, Nai86b, Ski80]. **Ordering** [Dud80]. **Ordinal** [McC85]. **Oriented** [Cru82, Mac81]. **Origin** [CA81, SS87]. **Orthogonal**
[AD83, BD82a, Che89, GND82, NG85, PM89, Nac87b]. **Orthogonality** [BW81]. **Osborn** [Ree81]. **Osborne** [Lak87]. **Other**
[BH84, Col88b, GS82, HR88, Sne81, Wal89, Wel82]. **Ott** [Pry89]. **Ott.** [War87a]. **Ottawa** [Fed84d]. **Outer** [Ano84e, CJJ81]. **Outgoing** [HH81].

**Outlier** [AC89, GH81, Jai81, MG85, Pie89, Ros83]. **Outlier-Induced** [MG85]. **Outliers** [AW80, BH82, CTC88, CP81, DJ80, DJ81, GCR86, HBK84, Kit79, Mar85, Gen80, Kit81, Sch86c, You80]. **Outlying** [Ano90a, Sim88a]. **Output** [Zie89x]. **Overview** [AL82, Dud80, Fer82, GPS82a, GPS82b, Jae82, LD82, Mog82, Moo82, Mor82]. **Owen** [Hah81, Sch84c].

**P** [Aro85b, Boa85a, Bow83, Car88, Coh81, Cro88a, Cru82, Dea81, Dic89, Fed80d, Fed80a, Fed81g, Fed81c, Fed81b, Fed81e, Fed82b, Fed84b, Fre88, Gok81, Hau87, Hea82, Hor86, Jac85f, Jac85d, Joh82, Liu89, MF83, Mar88a, Mee86, Nyc89, Per82, Pro89a, Ran87, Roh83b, Rup87, Sch89d, Sys82, Tho88, Zie86b, Zie88k, Zie88z, Zie89x, Zie89g]. **P.-Th** [Liu89, Per82]. **Packages** [Zie88h]. **Pai** [Sin82]. **Paired** [Chr89, LC81]. **Pairwise** [Spu81]. **Pallaschke** [J.80c]. **Panchapakesan** [Dud82]. **Paper** [Cop83]. **Papers** [Han84a]. **Parameter** [Dea82, Fai88, FM80b, HW87, JT83, McL89, Mil80, Mor87, Pie87, SB83, SS80, Zie88z]. **Parameters** [BE80, BA89, CTC88, CA81, EBW81, Hsi86, Ket83, Mag80, ÖD85, Par81, SGN85, SH83, ST85, SB83, SBE88, Sin83, SS87, SS81, Suz85, YSOE84, Sin92]. **Parametric** [J.80a, Mil89]. **Pareto** [CJ86, HW87]. **Pareto-Logistic** [CJ86]. **Parsimonious** [FS89a, FS89b, Has89, Haw89]. **Parsimony** [LA81]. **Part** [Owe88]. **Partial** [Gla82, Mal86]. **Partially** [Che85, Hil80, Khu84, PM89, Sin87]. **Particle** [BJ87]. **Particulate** [Bil84, Ven82]. **Parzen** [Aro85c]. **Pascal** [Edd87]. **Passenger** [Fed82a]. **Patel** [Aro83]. **Path** [Sys82]. **Patil** [Joh82]. **Pattern** [Cre87, Fed84b, Zai87, Nai88a]. **Patterson** [Sal89]. **Paul** [Hor82, Jac85e, Per89]. **Paula** [Was89]. **PC** [Zie88h]. **Pearson** [Hea89, Hel87]. **Peck** [Gib83, Kot88]. **Pellaumail** [Roh81]. **Percentage** [Jai81, Koz80, Ros83, Wil83]. **Percentile** [Mag80]. **Percentiles** [Boo84, Koe83]. **Perform** [Car87a, Col88a, She81a]. **Performance** [Boa87, BF87, Box88a, Box88b, CR88, Deh87b, Eas87, Gun88b, Han84b, KL88a, KL88b, LSK87a, LSK87b, MS82, Mau84, Nai88b, NP88a, Par88b, Pie87, PR87, Rob88, STL88, Ull88, Wu87]. **Period** [ASVR85]. **Periodic** [New82, Vec85]. **Periodogram** [BLSF88]. **Perryman** [Aro84a, Par83]. **Personal** [Zie89q]. **Personalities** [Far88a]. **Perspective** [LM82, LM85]. **Perspectives** [Zie88u]. **Pertinent** [Zie88l]. **Peter** [Dri89, Pie89, Por82b]. **Peters** [Far88a]. **Petersen** [Caf87]. **Petr** [Fed80b]. **Pfaffenberger** [Sal89]. **Pharmaceutical** [Ker85]. **Phase** [Kao88, Wor83]. **Phase-Type** [Kao88]. **Phenomena** [Che83]. **Philip** [Has88]. **Phillip** [Bem89]. **Philosophy** [Zie88-27]. **Physical** [Che83, Sid82]. **Piegorsch** [GGP87]. **Piepel** [Ano90c]. **Pierre** [Bil84]. **Piersol** [Iye87, Tuc82]. **Pike** [Der88]. **Pinto** [Che83]. **Pitman** [Har80]. **Plackett** [Zie87c, Zie87b, Bis83]. **Plan** [AB85, Kan87a, KN84, Kre87]. **Planning** [Lam84c, PS87]. **Plans** [Ano85e, Che89, EM82, FM80b, GND82, Hah81, HH81, Mee84b, NG85, PM89, Sch84c, Sch89b, SY87, WLP85, Yan83, She81b]. **Plot** [Mea89]. **Plots**

[FF89, JM87, Wan87, Pro87b, Wei87]. **Point**
[Cas82, Cre87, GC85, Hen86, Lom86, Fed82b]. **Points** [Dra82, Ham85, Jai81, Koz80, Lin81b, Lom88, Mag80, Ros83, Rub80, SKC83, Wil83]. **Poisson**
[Lee80b, MB88]. **Policy** [Jac80d, Lam84c]. **Policymaking** [Jac80d]. **Pollock**
[Jac80c]. **Pollution** [War88]. **Polynomial** [KC81, Pie86]. **Pool** [WTA80].
**Poor** [Gau88]. **Poor-Quality** [Gau88]. **Population**
[HZ80, Mee87b, DM87, DM88]. **Populations**
[FM80b, Sin83, Sin92, Dud82, Mor88a]. **Possible** [GCR86]. **Potential**
[Zai87]. **Potter** [Zie88t]. **Powders** [Bil88b]. **Power**
[Atk83, MG84, Mul89, Nel85, Tsa88]. **Power-Generating** [MG84].
**Prabhakar** [Vin89]. **Practical** [Kan87a, Ker85, Lee89a, Wat84, Zah89, Cro88a, Obr81, Pro89a, Swa80, Zie88e, Zie89m]. **Practice**
[Aro84c, Aro84d, Aro86b, Aro86a, Box84, Fed84e, Han84a, Nai88a, Zie89g, Bil84, Jac85e, Zie88y]. **Practitioners** [Tho88]. **Prague** [Fed80b]. **Pranab**
[Bas86, Joh83]. **Pre** [Sch85g]. **Pre-1950** [Sch85g]. **Precise** [HW85].
**Precision** [GS82]. **Prediction** [BT82, BD84, CG82, CO86, EB82, EN80, FMM80, GJM89, HR88, MH80, NW77, OL81, RHM87]. **Predictor** [BD82b].
**Pregibon** [Lit85]. **Prentice** [Kle82]. **Presence** [CTC88, MM83c].
**Presented** [Han84a]. **Press** [Zie87d]. **Pressure** [LRS82]. **Pressure-Volume**
[LRS82]. **Priestley** [Pre83b]. **Primer** [Mye80]. **Principal**
[CLS86, EK82, McC84, Goo88]. **Principes** [Pil83a]. **Principles**
[Boe83, Far88a, Joh83, Wei83, Zie88-27]. **Pringle** [Dal87]. **Prior** [PG86].
**Priorities** [PBT85]. **Prizes** [LD80]. **Probabilistic** [Par82]. **Probabilities**
[Bai80b, BS81, Hei80a]. **Probability**
[Aro85a, Fed81f, FF89, HWW85, QK82, Rey88, Roh83b, Sha82, Syl88, Zie88o, Zie88s, Jon89b, Sid80, Swa81a, Bor89, Gbu81, Gol88, Hod89].
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[BR87, Eas81, HR88, Hen86, Hil81, HL81b, HL81a, Law81, Lom86, Lwi81, Orb81, RS81, TW87, HL84]. **Problems**
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**Square** [Sch89a]. **Squared** [BD84, SK84]. **Squares** [BW81, DS87, GZ79, HMS81, ÖD85, Rub80, SMV82]. **Srivastava** [Sch84a, Fed81a]. **Stable** [Sys82]. **Stage** [BSA81, Che87, Fai88, MS82, Mau84, PD80b]. **Stahel** [Rup87]. **Stainton** [Sch81b]. **Standard** [Cor80, Gal88, Kat82, MD80, VIC89]. **Stanley** [Agr89, Hor82]. **Start** [LC82]. **STAT** [Sch82]. **State** [Ano80g, McD79, Sys82, Wel89]. **Stationary** [BA89, Sid82, Sys82]. **Statistic** [FM80a, Lit85, MTL82, Ski80, SM81, Wei81]. **Statistical** [AL82, Ano86e, Asc83, Bat88, Bea83, Bir83, Bor89, Cha89, Col88a, Cru84, DZ88, Dun89, Ell82, Eng83, Ens80, Eva83, Far88a, Fed81g, Fed81k, Fed84a, Fer82, Gar85, Gle84, GPS82a, GPS82b, Goo87, Gos86, GS82, Gun84, Gun85a, Har83, Har80, Has88, Jac86b, Jae82, Joh87, Joh83, Jol88, Kle82, Law83a, Law83b, LD82, Liu89, Lor80, Mat80, Maz88, Mee83, Min86, Mog82, Moo82, Mor82, Owe88, Owe89, Per82, PBT85, Pie88a, Pry89, Que88, Ran86, Ree88, RG86, San89, Sch88, Sch83c, Sch81b, Sch85c, Sch86c, Sch86b, Sch86a, Ski83, Smi87, Ste89a, Tho83, Woo86, You80, Zie87c, Zie87b, Zie87g, Zie88l, Zie88d, Zie89p, Zie89e, Zie89w, Zie89l, And86, Bai80a, Ber82c, Bin89, Bry89, Cal88, Cor81, Cru82, Edd87, Gbu83, Gho88, Gri88, Hac80, Hor86]. **Statistical** [Hsi87, Joh82, Koc81, Mar88b, Maz87, Mee82, Mie82, Min87, Mul89, Per88, Rea89, Ree81, Rel82, Rig88, Sal86, Sal89, Sch83b, Sch84f, Sch89d, Sin82, Ste89b, Thi88, Tho88, War88, Zie87e, Zie88y, Zie88g, Zie88h, Zie89r, Zie89s]. **Statisticians** [Aro85d, Pri85, Sch84g]. **Statistics** [Aro85b, Ber83, Boe83, Box84, Boy80, Cro88a, Deh87a, Fed81j, Fed81f, Fed81k, Fed81c, Fed81e, Fed84a, Fed84d, Fed84b, Gbu81, Gib88, Gol88, Gru88b, Han89, Hau87, Hea89, Hei80b, Igl88, Ker85, Khu87, Koz80, KE80, Lin81b, Mee87a, Mee85, Mee86, Mye80, Pen81, Pro89a, Rab89, Ran87, Rey88, Rup87, Sch82, Sch84d, Sch85b, Sch85g, Scl81a, Smi88, Spr83, Sto80, Syl81, Tup89, Wat82, Zie88b, Zie88c, Zie89h, Zie89c, Zie89m, Zie89j, vT88, Sin80, Ams87, Bro89, Bul89, Dal87, Far88b, Fed80b, Fed82c, Gru88a, Gun87, Han88, Har89a, Hod87, Hub89, Jac80b, Jac80a, Low82, Low83a, Mac83, MM82b, Min88, Obr81, Obr82a, Pig88, Por82b, Pro88b, Ran82, Rus88, Sav83, Sch84a, Sch85d, Sch85e, Scl81b, Sin80, Sto80, Syl88, Ter89, Zah89, Zie86a, Zie88k, Zie88o, Zie88n]. **Statistics** [Zie88s, Zie88u, Zie88x, Zie88j, Zie89i, Zie89b, Zie89p, Zie89k, Zie89n, Bor86, Bow83, Der89, Fed84d, Ful89, Gro89, Hix87, Kot88, Lam84c, Lan88, McL88, Obr82b, Pro87a, Pro88a, Roh83b, She87, She89, Shu87, Zie87f, Zie88i, Zie89u, Zie89t]. **Statistik** [Sch84b]. **Statistiques** [Pil83b]. **Statlib** [Ell82]. **STD** [JT83]. **Stein** [JO86]. **Stepanek** [Yfa87]. **Stephen** [Agr89, Zie86a, Zie88j]. **Stephens** [Car87a, Syl87, Kin87, She81a]. **Stepping** [Ano90a, Sim88a]. **Steps** [Lee89a]. **Stepwise** [RL80]. **Steven** [Gup82]. **Stewart** [Ano82f, Min87]. **Steyn** [Gri89]. **Stigler** [Zie88j]. **Stochastic** [Bac80, Cle80, Coh81, Cop83, EL81, Fed81h, Fed81b, Hor80a, Hor80b, Kim82, MW80b, MW80a, MHW84, Roh83a, Sta88, Tuc84, EL83, Ang89, Boo88, Jon88, Kal83, Roh81, Tay83, Zie88z]. **Stone** [Han89]. **Stoodley** [Sch81b]. **Stopping** [WD81]. **Straight** [Igl88]. **Stratified** [Mee89a]. **Strength**

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**T** [Bin89, Bow83, Far88b, Goo88, Hau89, Joh87, Lee81, McL88, MM82b, Ree88, Sch81b, Sch86a, Sin82, Ste89b, Zie88k, Zie88z, Zie89g]. **Table** [McC87, Wil83]. **Tables** [Ano90a, BD82a, BT83, BH82, Cor80, DJ80, Fed84a, Fra84, Gan81, Hea89, Khu87, Lin81b, Sch84f, Sch84c, Sim88a, Spr83, Tho86, Gen80, Odo80, Hah81, Sch85f]. **Tabulation** [BSMB82]. **Taguchi** [Pie90, AW89, Bis89, DZ88, LSK87a, Par89, Sen89, Bem89]. **Taillie** [Joh82]. **Takes** [Pie88b]. **Takesi** [Goo87]. **Takeuchi** [Gup83]. **Talk** [Igl88]. **Tamhane** [Lit89]. **Tampere** [Zie89n]. **Tan** [Roc87b]. **Tanis** [Bor89]. **Tapiero** [Fed81i, Fed81b]. **Tarmo** [Zie89n]. **Taylor** [Zie89o]. **Teaching** [Fed82c, Low82, Zah89]. **Technician** [Pla88]. **Technique** [BH80, Mea89, Yas89]. **Techniques** [Bem89, Fed81h, Gri88, Gun85c, Har89b, HSH86, Hoe87, Min87, Bai80a, Gbu83, Kin87, Sch81b, Sch85b]. **Technometrics** [BR89, BT98, BM87b, Cro89, DM88, EL83, FHL81, Hsi80, HL84, IC89, Kit81, LM85, NP89, Sin92, Ste90, WB88a, Eas83c]. **Tell** [Pri85]. **Tenth** [Lam84b]. **Ternary** [GC85]. **Terry** [Der89, Ful89]. **Test** [BS83, Car80, Col88b, Fai88, FM80b, Gan81, GM86, Haw81, HM84, Hsi86, JT83, Kan87a, Khu85, LM80, MLG82, Mee84b, SB83, SBE88, Sin83, YY87, Hsi80, Sin92]. **Testing** [Agr86b, Ber82a, BB89, BJ86, DJ80, EJG84, Hsi81, Lee80b, Lik82, MJ81,

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Car80, Che87, Cro86b, DJ80, Fai88, FM80b, GH81, GH80, Hsi81, Koz80, KE80, MS82, Mau84, Mil80, MM83c, Pie87, SB83, Sim88a, Ski80, SC82, SMV82, Spr83, Wal86, WTA80, Woo84, Wor83, Cro89, Gen80, Hsi80, OCO89]. **Two-** [GH81]. **Two-Level** [MM83c]. **Two-Parameter** [FM80b, Mil80, Pie87]. **Two-Phase** [Wor83]. **Two-Sample** [SB83]. **Two-Sided** [BT89, Cro86b, Wal86, Woo84, BT98, Cro89, OCO89]. **Two-Stage** [BSA81, Che87, Fai88, MS82, Mau84]. **Two-Way** [Ano90a, BH82, DJ80, GH80, Sim88a, Ski80, WTA80, Gen80]. **Type** [Agr86a, Kao88, Sin92, SM81, Hsi86, Mee84b, Pie87, Sin83].

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[Ano86e]. **Volume**
[Ano80p, Ano81m, Ano82o, Ano83m, Ano84n, Ano85l, Ano86j, Ano87i, Ano88i, Ano89i, Boa85b, Cre87, Fed81c, Fed81e, Fed84b, Har83, LRS82, Lin81b, Ran87, Sch85a, Sch86b, Was89, Zie87c, Zie87b, Car87a, Car87a, Col88b, Col88a, Kan87b, Kan87a, Pro87b, Pro87c, Pro87d, Zie87h]. **Volumes** [Zie88-28].

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